Search Notes

Application/Control No.	Ā
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Applicant(s)/Patent under Reexamination
O'TOOLE ET AL.

10/719,385 Examiner

Art Unit

Yunsoo Kim

1644

SEARCHED				
Class	Subclass	Date	Examiner	
530	350	1/27/2005	YK	
514	2	1/27/2005	YK	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
seq ID No:2,20,26 search from STIC	1/3/2005	YK	
domestic priority 60/428,094 11/21/02	1/28/2005	YK	
inventor search from PALM	1/28/2005	YK	